**REVISIONS** LTR DESCRIPTION DATE APPROVED Convert to Military drawing format. 15 JAN Add vendor 01295 for device type 01RX and 012X. REV PAGE REV **REV STATUS** Α Α Α Α Α **OF PAGES PAGES** 5 6 8 9 10 PREPARED **Defense Electronics Supply Center** unstall This drawing is available for use by Dayton, Ohio all Departments and Agencies of the Department of Defense TITLE: MICROCIRCUIT, DIGITAL, HIGH-SPEED CMOS, WITH LSTTL COMPATIBLE INPUTS, BUFFER/LINE DRIVER/RECEIVER, MONOLITHIC SILICON Original date of drawing: 3 March 1986 CODE IDENT. NO. SIZE DWG NO. 14933 AMSC N/A REV PAGE OF 1 Α 5962-E205-1

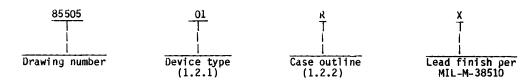
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 $1.1\,$  Scope. This drawing describes device requirements for class B microcircuits in accordance with  $1.2.1\,$  of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices".

1.2 Part number. The complete part number shall be as shown in the following example:



1.2.1 Device type. The device type shall identify the circuit function as follows:

Device type Generic number Circuit

54HCT240 Octal 3-state inverting buffer/line receiver/line driver

1.2.2 Case outlines. The case outlines shall be as designated in appendix C of MIL-M-38510, and as follows:

Outline letter

Case outline

D-8 (20-lead, 1/4" x 1-1/16"), dual-in-line package C-2 (20-terminal, .350" x .350"), square chip carrier package

1.3 Absolute maximum ratings. 1/

Supply voltage range - - - --0.5 V dc to +7.0 V dc -0.5 V dc to V<sub>CC</sub> +0.5 V dc -0.5 V dc to V<sub>CC</sub> +0.5 V dc ±20 mA ±35 mA ±70\_mA -65°C to +150°C Maximum power dissipation ( $P_D$ ) - - - - - - - Lead temperature (soldering 10 seconds) - - - -500 mW 2/ +260°C Thermal resistance, junction to case  $(\theta_{JC})$ : See MIL-M-38510, appendix C 60°C/W 3/ Case 2 - - - - - - - - - -+175°C Junction temperature  $(T_J)$ ------

Unless otherwise specified, all voltages are referenced to ground.

For  $T_C = \pm 100^{\circ} C$  to  $\pm 125^{\circ} C$ , derate linearly at 12 mW/ $^{\circ} C$ . When a thermal resistance for this case is specified in MIL-M-38510, appendix C, that value shall supersede the value specified herein.

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1.4 Recommended operating conditions.

Supply voltage ( $V_{CC}$ ) - - - - - - - - - - - +4.5 V dc to +5.5 V dc case operating temperature range ( $T_C$ )- - - - - - - - - - - - - 55 °C to +125 °C Input rise or fall time:  $V_{CC}$  = 4.5 V - - - - - - - - - - - - - - 0 to 500 ns

2. APPLICABLE DOCUMENTS

2.1 <u>Government specification and standard</u>. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510

Microcircuits, General Specification for.

**STANDARD** 

MILITARY

MIL-STD-883

Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

- 2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.
  - 3. REQUIREMENTS
- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN devices" and as specified herein.
- 3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
  - 3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.
  - 3.2.2 Truth table. The truth table shall be as specified on figure 2.
  - 3.2.3 Logic diagram. The logic diagram shall be as specified on figure 3.
  - 3.2.4 <u>Case outlines</u>. The case outlines shall be in accordance with 1.2.2 herein.
- 3.3 Electrical performance characteristics. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full recommended case operating temperature range.
- 3.4 <u>Marking</u>. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.

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Toot	Cumb ol	7	Candibi	1/	10	A	Li	mits	l Und A
Test	Symbol     	     	Conditi -55°C < T <sub>C</sub> unless otherwi	ons 1/ < +125°C se specified	Grou  subg 	p A roups	Min	Max	Unit     
High level output voltage	V <sub>OH</sub>	l	V <sub>IH</sub> or V <sub>IL</sub> < 20 μA	V <sub>CC</sub> = 4.5 V	1,	2, 3	4.4		V 
		Į.	VIH or VIL ≤ 6.0 mA	V <sub>CC</sub> = 4.5 V	1,	2, 3	3.7	     	٧
Low level output voltage	V <sub>OL</sub>	1	V <sub>IH</sub> or V <sub>IL</sub> < 20 μA	V <sub>CC</sub> = 4.5 V	1,	2, 3     		0.1	٧
		1	VIH or VIL	V <sub>CC</sub> = 4.5 V	1,	2, 3     		0.4	٧
High level input voltage	YIH		2/	V <sub>CC</sub> = 4.5 V	11,	2, 3	2.0	i i i	٧
Low level input voltage	\v_IL	     	2/	V <sub>CC</sub> = 4.5 V	1,	2, 3		0.8	٧
Input capacitance	CIN	  V <sub>IN</sub> =  See 4.	0 V 3.1c	T <sub>C</sub> = +25°C	4	 		10	pF
Quiescent current	Icc	V <sub>CC</sub> =	5.5 V; V <sub>IN</sub> = V	CC or GND	1, 1	2, 3   		160	μΑ
Input leakage current	IIN	V <sub>CC</sub> =	5.5 V; V <sub>IN</sub> = V	CC or GND	1, 1	2, 3   		±1	μА
unctional tests		See 4.	3.1d		7	]   			
Three state output current	I <sub>OZ</sub>	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	VIH or VIL;		1, 2	2, 3		±10	μА
See footnotes at end of	table.								
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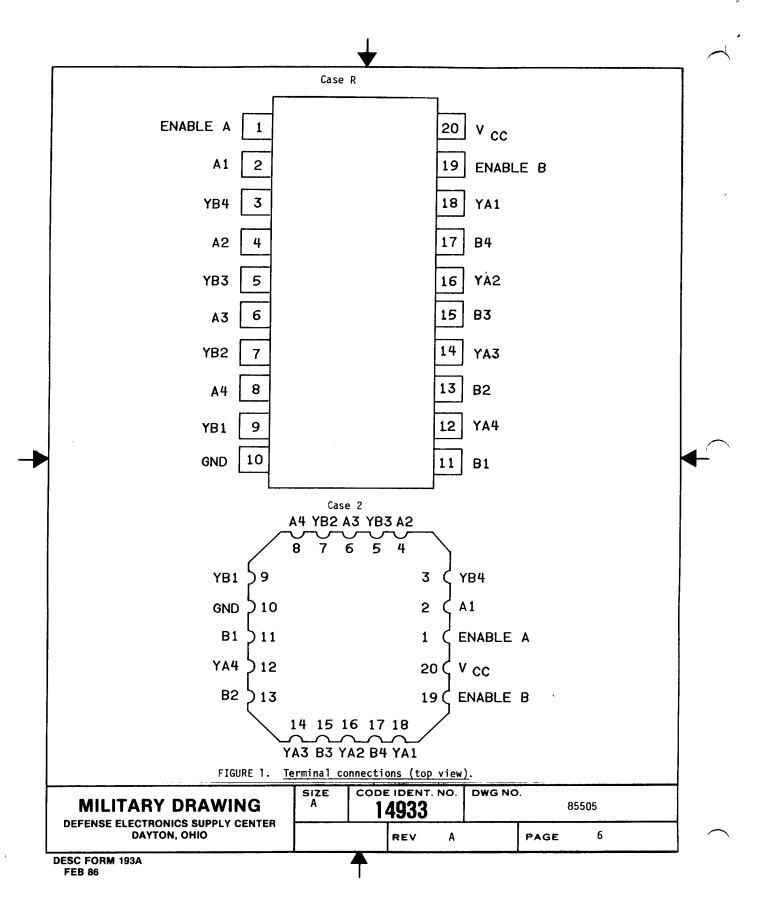
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TABL	El. Ele	ctrical performance characteristics -	Continued.			
Test Symb	  Symbol	Conditions 1/	Group A	Lin	Unit	
		Conditions 1/   -55°C < T <sub>C</sub> < +125°C   unless otherwise specified	subgroups	Min	Max	T   
dditional quiescent supply current	ΔICC	$ V_{IN}\>=2.4$ V or 0.5 V, any 1 input $ V_{IN}\>=V_{CC}\>$ or GND, other inputs $ V_{CC}\>=5.5$ V $ I_{OUT}\>=0~\mu A$	1, 2, 3	i 	3       	mA       
Propagation delay time, A to YA or B to YB	  t <sub>PHL</sub>  t <sub>PLH</sub>		[   9 		25 	l ns
	   	  See figure 4 	10, 11		1   38 	l ns
Propagation delay time, output enable to YA	  tpLZ  tpHZ	 	9		   35 	ns
or YB	2	 	10, 11		53 	l i ns l
ropagation delay time, output enable to YA	t <sub>PZL</sub>		9		35 	i ns
or YB		 	10, 11		53	i ns
ransition time $3/$	tTLH ItTHL		9		12	ns
	1	 	10, 11		18	ns

For a power supply of 5 V  $\pm 10\%$  the worst case output voltages (V<sub>OH</sub> and V<sub>OL</sub>) occur for HCT at 4.5 V. Thus the 4.5 V values should be used when designing with this supply. Worse case V<sub>IH</sub> and V<sub>IL</sub> occur at V<sub>CC</sub> = 5.5 V and 4.5 V respectively.

- $\underline{2}/$  Test not required if applied as a forcing function for  $v_{0H}$  or  $v_{1L}$ .
- $\frac{3}{2}$  Transition time, (t<sub>TLH</sub>, t<sub>THL</sub>), if not tested, shall be guaranteed to the specified parameters.

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Input	Outputs	
Enable A Enable B	YA,YB	
L	L	Н
L	Н	L
Н	Х	Z

Z = High Impedance

X = Don't Care

FIGURE 2. <u>Truth table</u>.

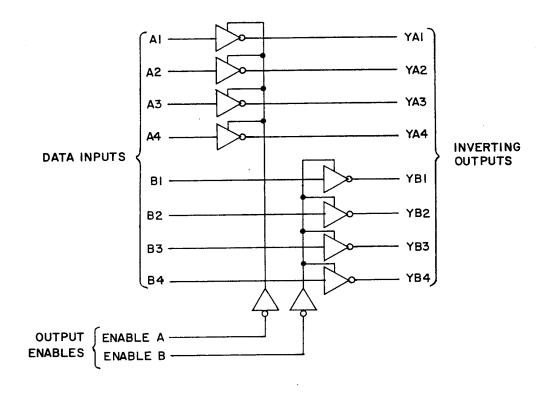
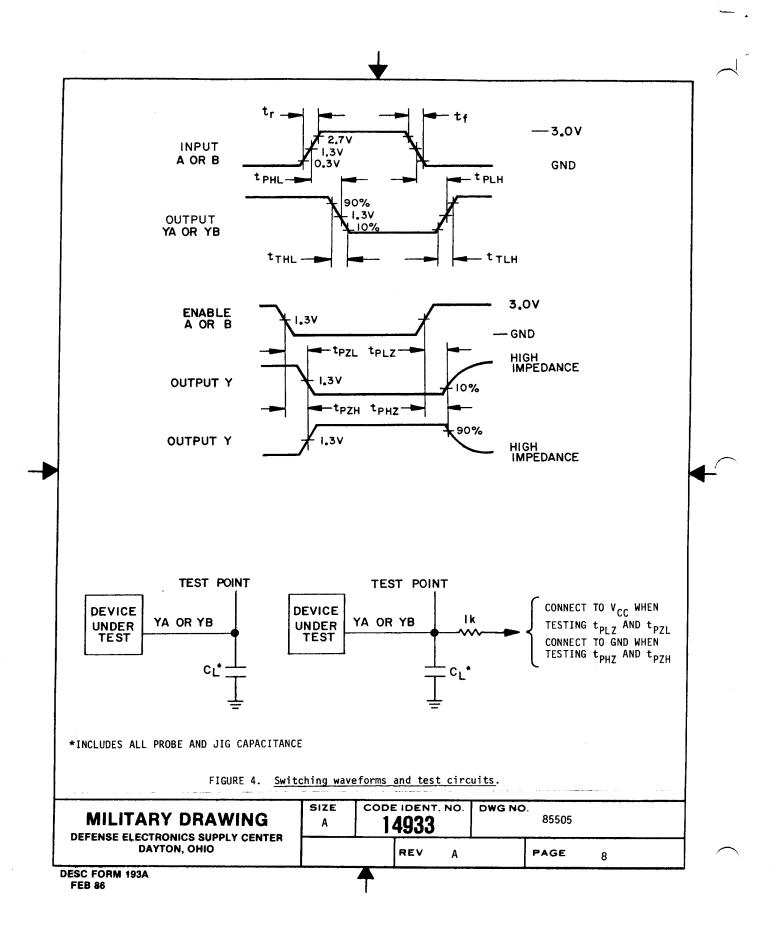
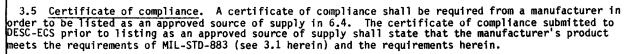


FIGURE 3. Logic diagram.

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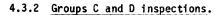
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- 3.6 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.
- 3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.8 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
  - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 Screening. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
  - Burn-in test (method 1015 of MIL-STD-883).
    - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
    - (2)  $T_A = +125$ °C, minimum.
  - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-STD-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
  - 4.3.1 Group A inspection.
    - a. Tests shall be as specified in table II herein.
    - b. Subgroups 5, 6, and 8 in table I, method 5005 of MIL-STD-883 shall be omitted.
    - c. Subgroup 4 (C  $_{\rm IN}$  measurement) shall be measured only for the initial test and after process or design changes which may affect input capacitance.
    - d. Subgroup 7 tests shall verify the truth table.

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- a. End-point electrical parameters shall be as specified in table II herein.
- b. Steady-state life test (method 1005 of MIL-STD-883) conditions:
  - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
  - (2)  $T_A = +125^{\circ}C$ , minimum.
  - (3) Test duration: 1,000 hours, except as permitted by appendix B of MIL-M-38510 and method 1005 of MIL-STD-883.

TABLE II. Electrical test requirements.

	<del></del>
	Subgroups
MIL-STD-883 test requirements	(per method
	5005, table I)
1	
Interim electrical parameters	
(method 5004)	:
	<u> </u>
Final electrical test parameters	
(method 5004)	1*,2,9
Group A test requirements	
(method 5005)	1,2,3,7,9,
	10,11**
Groups C and D end-point	<del></del>
l electrical parameters	1,2,3
(method 5005)	i
(	i
Additional electrical subgroups	· · · · · · · · i
for group C periodic inspections	Ì
	i
	<del> </del>

- PDA applies to subgroup 1.
- \*\* Subgroup 10 and 11, if not tested, shall be guaranteed to the specified limits in table I.

## 5. PACKAGING

- 5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.
- NOTES
- 6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
  - 6.2 Replaceability. Replaceability is determined as follows:
    - a. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
    - b. When a QPL source is established, the part numbered device specified in this drawing will be replaced by the microcircuit identified as part number M38510/65753B--.

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- 6.3 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.
- 6.4 Approved sources of supply. Approved sources of supply are listed herein. Additional sources will be added as they become available. The vendors listed herein have agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military drawing   part number	Vendor   CAGE   number	Vendor similar part number 1/	Replacement    military specification    part number
8550501RX	01295 04713 18714	  SNJ54HCT240J  54HCT240/BRAJC  CD54HCT240F/3A 	M38510/65753BRX
   85505012X   	04713 01295	  54HCT24OM/B2CJC  SNJ54HCT24OFK 	M38510/65753B2X

Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number	Vendor name <u>and address</u> Motorola, Inc . 7402 S. Price Road Tempe, AZ 85283				
04713					
18714	RCA Corporation Route 202 Somerville, NJ 08876				
01295	Texas Instrument, Inc. P.O. Box 6448 Midland, TX 79701				

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